

Dual P-Channel Enhancement Mode MOSFET

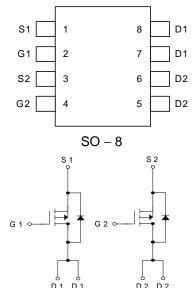
Features

- -20V/-6A, $R_{DS(ON)}$ =30mΩ(typ.) @ V_{GS} =-4.5V $R_{DS(ON)}$ =38m Ω (typ.) @ V_{GS} =-2.5V
- Super High Dense Cell Design for Extremely Low R_{DS(ON)}
- Reliable and Rugged
- SO-8 Package

Applications

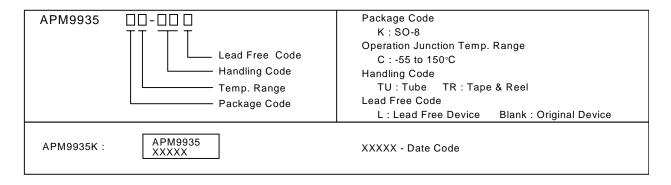
Power Management in Notebook Computer, Portable Equipment and Battery Powered Systems.

Pin Description



Ordering and Marking Information

P-Channel MOSFET



Absolute Maximum Ratings (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Rating	Unit	
V_{DSS}	Drain-Source Voltage -20		1.7	
V_{GSS}	Gate-Source Voltage	±12	V	
I _D	Maximum Drain Current - Continuous	-6	٨	
I _{DM}	Maximum Drain Current – Pulsed	-20	Α	

ANPEC reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.



Absolute Maximum Ratings (Cont.) $(T_A = 25^{\circ}C \text{ unless otherwise noted})$

Symbol	Parameter		Rating	Unit	
P _D	Mariana Baran Birainatian	T _A =25°C	2	W	
	Maximum Power Dissipation T _A	T _A =100°C	0.8		
TJ	Maximum Junction Temperature		150	20	
T _{STG}	Storage Temperature Range		-55 to 150	°C	
$R_{\thetaJA}^{}^{\star}}$	Thermal Resistance – Junction to	o Ambient	62.5	°C/W	

^{*} Mounted on 1in² pad area of PCB.

Electrical Characteristics $(T_A = 25^{\circ}C \text{ unless otherwise noted})$

Cum h a l	Parameter	Test Condition	А	APM9935			
Symbol	Parameter	lest Condition	Min.	Тур.	Max.	Unit	
Static							
BV _{DSS}	Drain-Source Breakdown Voltage	V_{GS} =0V , I_{DS} =-250 μ A	-20			V	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-16V , V _{GS} =0V			-1	μΑ	
V _{GS(th)}	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{DS}=-250\mu A$	-0.5	-0.7	-1	V	
I _{GSS}	Gate Leakage Current	V _{GS} =±12V , V _{DS} =0V			±100	nA	
R _{DS(ON)} ^a	Drain-Source On-state Resistance	V _{GS} =-4.5V , I _{DS} =-6A		30	45	_	
NDS(ON)	Drain-Source On-state Resistance	V _{GS} =-2.5V , I _{DS} =-5A		38	65	mΩ	
V _{SD} ^a	Diode Forward Voltage	I _S =-2A , V _{GS} =0V		-0.7	-1.3	V	
Dynamic ^b		•	•	•	•		
Qg	Total Gate Charge	V _{DS} =-10V , I _{DS} =-6A		17	25		
Q _{gs}	Gate-Source Charge	V _{GS} =-4.5V		5.2		nC	
Q_{gd}	Gate-Drain Charge	V GS=-4.5 V		3.6			
t _{d(ON)}	Turn-on Delay Time	V _{DD} =-15V , I _{DS} =-6A ,		12	25		
T _r	Turn-on Rise Time	$V_{\text{DD}} = -15 \text{ V}, I_{\text{DS}} = -6 \text{ A},$ $V_{\text{GEN}} = -4.5 \text{ V}, R_{\text{G}} = 10 \Omega$		18	35		
t _{d(OFF)}	Turn-off Delay Time	V _{GEN} =-4.5V , N _G =1022		40	80	ns	
T _f	Turn-off Fall Time	1		20	40		
C _{iss}	Input Capacitance	V 0V V 45V		1665			
Coss	Output Capacitance	-V _{GS} =0V , V _{DS} =-15V -Frequency=1.0MHz		380		pF	
C _{rss}	Reverse Transfer Capacitance	Trequency=1.0MITZ		290			

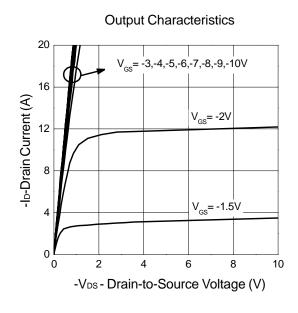
Notes

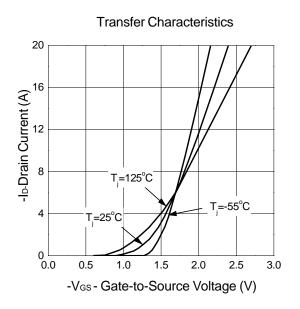
 $^{\text{a}}$: Pulse test ; pulse width ${\leq}300\mu\text{s},$ duty cycle ${\leq}~2\%$

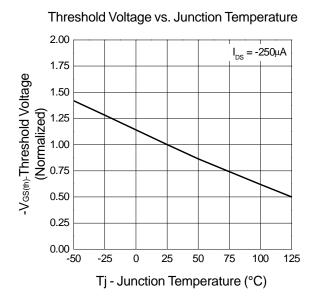
b: Guaranteed by design, not subject to production testing

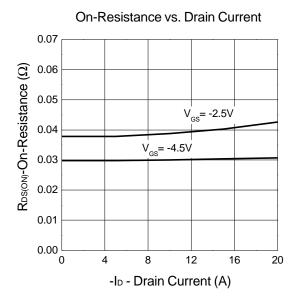


Typical Characteristics



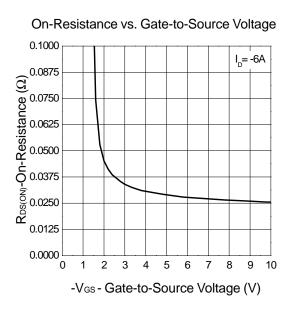


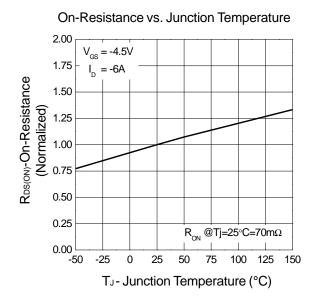


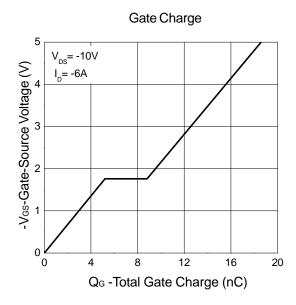


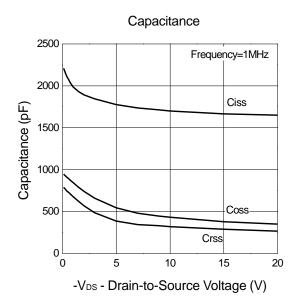


Typical Characteristics (Cont.)



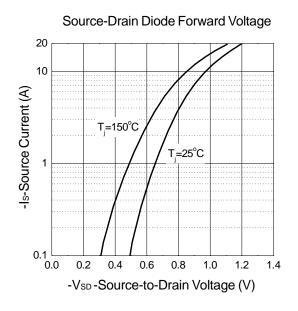


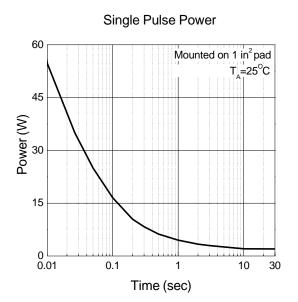




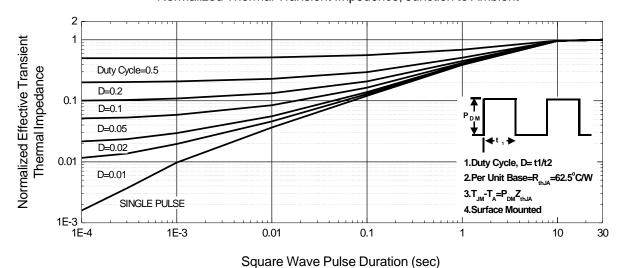


Typical Characteristics (Cont.)





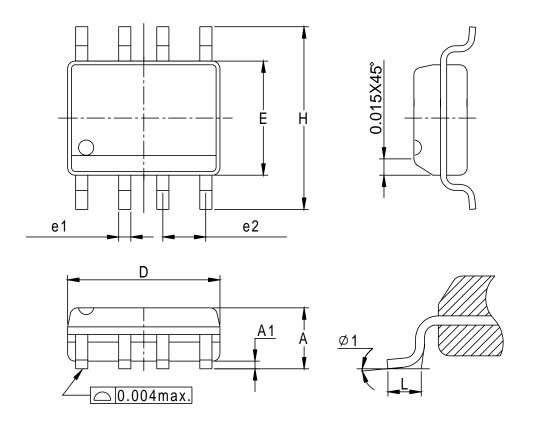
Normalized Thermal Transient Impedence, Junction to Ambient





Packaging Information

SOP-8 pin (Reference JEDEC Registration MS-012)



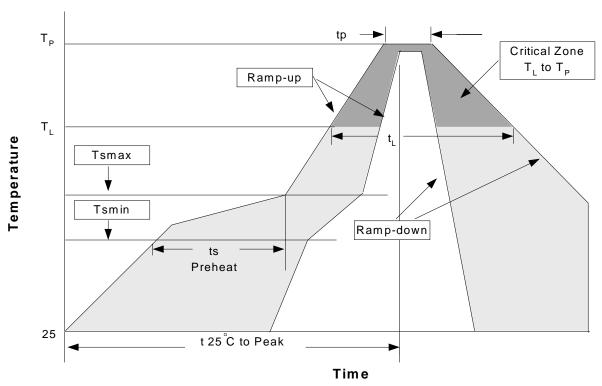
Dim	Millim	eters	Inch	nes
Dim	Min.	Max.	Min.	Max.
А	1.35	1.75	0.053	0.069
A1	0.10	0.25	0.004	0.010
D	4.80	5.00	0.189	0.197
E	3.80	4.00	0.150	0.157
Н	5.80	6.20	0.228	0.244
L	0.40	1.27	0.016	0.050
e1	0.33	0.51	0.013	0.020
e2	1.27BSC		0.50BSC	
ф 1	8°		8°	0



Physical Specifications

Terminal Material	Solder-Plated Copper (Solder Material : 90/10 or 63/37 SnPb), 100%Sn
Lead Solderability	Meets EIA Specification RSI86-91, ANSI/J-STD-002 Category 3.

Reflow Condition (IR/Convection or VPR Reflow)



Classificatin Reflow Profiles

Profile Feature	Sn-Pb Euted	tic Assembly	Pb-Free Assembly		
Profile Feature	Large Body	Small Body	Large Body	Small Body	
Average ramp-up rate $(T_L \text{ to } T_P)$	3°C/second max.		3°C/second max.		
Preheat - Temperature Min (Tsmin) - Temperature Mix (Tsmax) - Time (min to max)(ts)	100°C 150°C 60-120 seconds		150°C 200°C 60-180 seconds		
Tsmax to T _L - Ramp-up Rate	33 123 666611.03		3°C/second max		
Tsmax to T _L - Temperature(T _L) - Time (t _L)	183°C 60-150 seconds		217°C 60-150 seconds		
Peak Temperature(Tp)	225 +0/-5°C	240 +0/-5°C	245 +0/-5°C	250 +0/-5°C	
Time within 5°C of actual Peak Temperature(tp)	10-30 seconds 10-30 seconds		10-30 seconds 20-40 seconds		
Ramp-down Rate	6°C/second max.		6°C/second max.		
Time 25°C to Peak Temperature		tes max.	8 minute	es max.	

Note: All temperatures refer to topside of the package. Measured on the body surface.



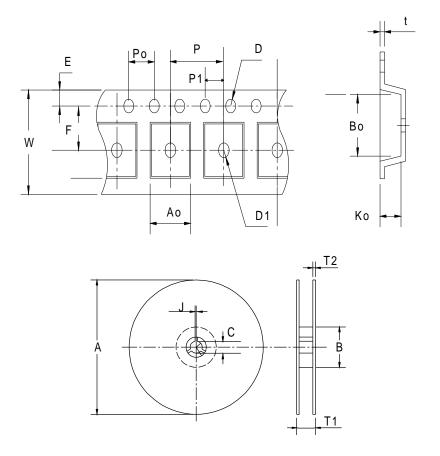
Package Reflow Conditions

pkg. thickness ≥ 2.5mm and all bgas	pkg. thickness < 2.5mm and pkg. volume ≥ 350mm ³	pkg. thickness < 2.5mm and pkg. volume < 350mm ³
Convection 220 +5/-0°C		Convection 235 +5/-0°C
VPR 215-219°C		VPR 235 +5/-0°C
IR/Convection 220 +5/-0°C		IR/Convection 235 +5/-0°C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	MIL-STD-883D-2003	245°C,5 SEC
HOLT	MIL-STD 883D-1005.7	1000 Hrs Bias @ 125°C
PCT	JESD-22-B, A102	168 Hrs, 100% RH, 121°C
TST	MIL-STD 883D-1011.9	-65°C ~ 150°C, 200 Cycles

Carrier Tape & Reel Dimensions





Carrier Tape & Reel Dimensions

Application	Α	В	С	J	T1	T2	W	Р	E
	330 ± 1	62 +1.5	12.75+ 0.15	2 ± 0.5	12.4 ± 0.2	2 ± 0.2	12± 0. 3	8± 0.1	1.75±0.1
SOP-8	F	D	D1	Po	P1	Ao	Во	Ko	t
	5.5± 1	1.55 +0.1	1.55+ 0.25	4.0 ± 0.1	2.0 ± 0.1	6.4 ± 0.1	5.2± 0. 1	2.1± 0.1	.3±0.013

Cover Tape Dimensions

Application	Carrier Width	Cover Tape Width	Devices Per Reel
SOP-8	12	9.3	2500

Customer Service

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